


<b>Search Notes</b>  	<b>Application/Control No.</b>  10511033	<b>Applicant(s)/Patent Under Reexamination</b>  MONIN ET AL.
	<b>Examiner</b>  Eunhee Kim	<b>Art Unit</b>  2123

SEARCHED			
Class	Subclass	Date	Examiner
703	22	6/10/2008	Eunhee Kim

SEARCH NOTES		
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